

<b>Notice of References Cited</b>	Application/Control No. 10/816,314	Applicant(s)/Patent Under Reexamination BABBAR ET AL.	
	Examiner THUAN T. NGUYEN	Art Unit 2618	Page 1 of 1

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*	C	US-6,317,597 B1	11-2001	Baker et al.	455/426.1
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	M	US-			

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**NON-PATENT DOCUMENTS**

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